SCBS731 – JULY 2000
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<ul> <li>BiCMOS Technology With Low Quiescent Power</li> </ul>	EN OR M PA (TOP VII	
Buffered Inputs		24 ] V <sub>CC</sub>
Noninverted Outputs	1D [ 2	23 ] 1Q
<ul> <li>Input/Output Isolation From V<sub>CC</sub></li> </ul>	2D 🛛 3	22 2 2Q
Controlled Output Edge Rates	· 1	21 🛛 3Q
• 48-mA Output Sink Current	3	20 4Q
•	5D [ 6	19 5Q
<ul> <li>Output Voltage Swing Limited to 3.7 V</li> </ul>	6D 🛛 7	18 6Q
<ul> <li>SCR Latch-Up-Resistant BiCMOS Process</li> </ul>	7D 🛿 8	17 🛛 7Q
and Circuit Design	8D 🛛 9	16 8Q
<ul> <li>Provide Extra Data Width Necessary for</li> </ul>	9D 🛿 10	15 9Q
Wider Address/Data Paths or Buses With	10D 🛽 11	14 ] 10Q
Parity	GND [ 12	13 CLK
Outputs Have Undershoot-Protection		

- Buffered Control Inputs Reduce dc Loading Effects
- Package Options Include Plastic Small-Outline (M) Package and Standard Plastic (EN) DIP

#### description

Circuitry

The CD74FCT821A is a 10-bit flip-flop that features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers with parity, and working registers.

This device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below  $V_{CC}$ . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes  $V_{CC}$  bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

The flip-flops enter data into their registers on the low-to-high transition of the clock (CLK). The Q outputs are noninverted data. The output-enable ( $\overline{OE}$ ) input controls the 3-state outputs and is independent of register operation. When  $\overline{OE}$  is high, the outputs are in the high-impedance state.

The CD74FCT821A is characterized for operation from 0°C to 70°C.

(each flip-flop)								
	OUTPUT							
ŌE	CLK	D	Q					
L	$\uparrow$	Н	Н					
L	$\uparrow$	L	L					
L	L	Х	Q <sub>0</sub>					
Н	х	Х	Z					

**FUNCTION TABLE** 



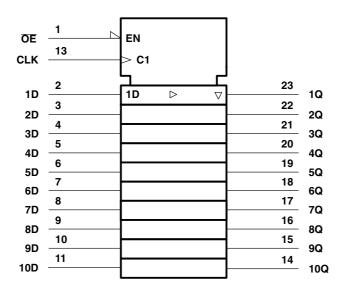
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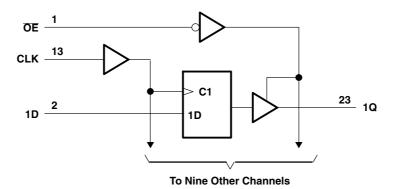
### CD74FCT821A BiCMOS 10-BIT BUS-INTERFACE FLIP-FLOP WITH 3-STATE OUTPUTS SCBS731 - JULY 2000

### logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>‡</sup>

DC supply voltage range, $V_{CC}$ DC input clamp current, $I_{IK}$ ( $V_{I} < -0.5 V$ ) DC output clamp current, $I_{OK}$ ( $V_{O} < -0.5 V$ ) DC output sink current per output pin, $I_{OL}$ DC output source current per output pin, $I_{OH}$ Continuous current through $V_{CC}$ , ( $I_{CC}$ ) Continuous current through GND Package thermal impedance, $\theta_{JA}$ (see Note 1): EN package M package	20 mA 50 mA 70 mA 260 mA 500 mA 67°C/W 46°C/W
Storage temperature range, T <sub>stg</sub>	

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.



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### recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.75	5.25	V
V <sub>IH</sub>	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	$V_{CC}$	V
Vo	Output voltage	0	$V_{CC}$	V
I <sub>OH</sub>	High-level output current		-15	mA
I <sub>OL</sub>	Low-level output current		48	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
T <sub>A</sub>	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEAT AGNIDITIONIA		T <sub>A</sub> = 25°C				
PARAMETER	TEST CONDITIONS	v <sub>cc</sub>	MIN	MAX	MIN	MAX	UNIT
V <sub>IK</sub>	$I_I = -18 \text{ mA}$	4.75 V		-1.2		-1.2	V
V <sub>OH</sub>	I <sub>OH</sub> = -15 mA	4.75 V	2.4		2.4		V
V <sub>OL</sub>	I <sub>OL</sub> = 48 mA	4.75 V		0.55		0.55	V
lı	$V_{I} = V_{CC}$ or GND	5.25 V		±0.1		±1	μA
I <sub>OZ</sub>	$V_{O} = V_{CC}$ or GND	5.25 V		±0.5		±10	μA
I <sub>OS</sub> †	$V_{I} = V_{CC} \text{ or } GND, \qquad V_{O} = 0$	5.25 V	-75		-75		mA
I <sub>CC</sub>	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.25 V		8		80	μA
$\Delta I_{CC}^{\ddagger}$	One input at 3.4 V, Other inputs at $V_{CC}$ or GND	5.25 V		1.6		1.6	mA
C <sub>i</sub>	$V_{I} = V_{CC}$ or GND			10		10	pF
Co	$V_{O} = V_{CC} \text{ or } GND$			15		15	pF

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

<sup>‡</sup> This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# timing requirements over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT
f <sub>clock</sub>	Clock frequency			70	MHz
t <sub>w</sub>	Pulse duration	CLK high or low	7		ns
t <sub>su</sub>	Setup time	Data before CLK↑	4		ns
t <sub>h</sub>	Hold time	Data after CLK↑	2		ns



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# switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 1)

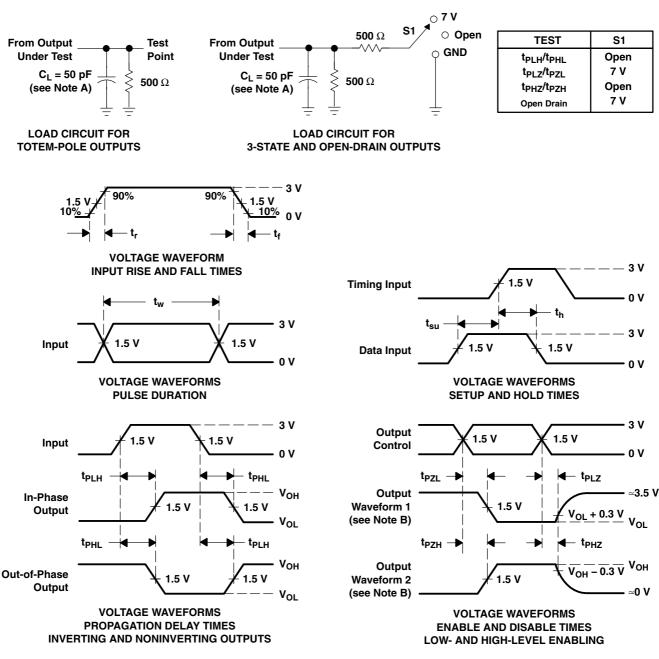
DADAMETED	FROM	то	T <sub>A</sub> = 25°C			
PARAMETER	(INPUT)	(OUTPUT)	ТҮР	MIN	MAX	UNIT
f <sub>max</sub>				70		MHz
t <sub>pd</sub>	CLK	Q	7.5	1.5	10	ns
t <sub>en</sub>	ŌĒ	Q	9	1.5	12	ns
t <sub>dis</sub>	ŌĒ	Q	6	1.5	8	ns

## noise characteristics, $V_{CC}$ = 5 V, $C_L$ = 50 pF, $T_A$ = 25°C

	PARAMETER	MIN	TYP	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		1		V
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>		0.5		V
V <sub>IH(D)</sub>	High-level dynamic input voltage	2			V
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.8	V



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PARAMETER MEASUREMENT INFORMATION

- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub> and t<sub>f</sub> = 2.5 ns. D. The outputs are measured one at a time with one input transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PHL}$  and  $t_{PLH}$  are the same as  $t_{pd}$ .







11-Apr-2013

### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
CD74FCT821AEN	OBSOLETE	E PDIP	NT	24		TBD	Call TI	Call TI	0 to 70		
CD74FCT821AM	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	0 to 70		
CD74FCT821AM96	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	0 to 70		

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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NT (R-PDIP-T\*\*) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



All integrations are in minimeters. Dimensioning and toil
 B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



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